GP2S40

Features

- 1. Ultra compact DIP package (Volume: 1/3 of **GP2S05**)
- 2. Long focal distance type (focal distance: 3mm)
- 3. Effective detection distance: 1.5 to 6.5mm

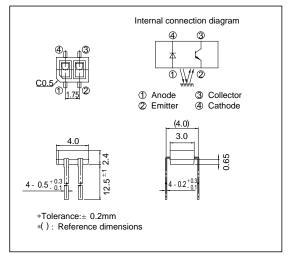
Applications

- 1. Copiers
- 2. Facsimiles
- 3. Printers

Long Focal Distance, Subminiature Photointerrupter

Outline Dimensions

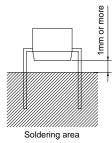
(Unit : mm)



Absolute Maximum Ratings

$(Ta = 25^{\circ}C)$

_ /	•		```	14 20 0)	
	Parameter	Symbol	Rating	Unit	
	Forward current	IF	50	mA	
Input	Reverse voltage	VR	6	V	
	Power dissipation	P _D	75	mW	
	Collector-emitter voltage	VCEO	35	V	
	Emitter-collector voltage	VECO	6	V	
Output	Collector current	Ic	20	mA	
	Collector power dissipation	Pc	75	mW	
	Total power dissipation	Ptot	100	mW	
Operating temperature		T opr	- 25 to + 85	°C	
	Storage temperature	T stg	- 40 to + 100	°C	
*1Soldering temperature		T sol	260	°C	



*1 For 5 seconds

" In the absence of confirmation by device specification sheets, SHARP takes no responsibility for any defects that occur in equipment using any of SHARP's devices, shown in catalogs, data books, etc. Contact SHARP in order to obtain the latest version of the device specification sheets before using any SHARP's device."

Electro-optical Characteristics

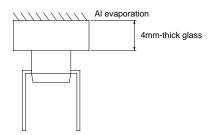
 $(Ta = 25^{\circ}C)$

	•							
Parameter			Symbol	Condition	MIN.	TYP.	MAX.	Unit
Input	Forward voltage		V _F	$I_F = 20 m A$	-	1.2	1.4	V
	Reverse current		IR	$V_R = 3V$	-	-	10	μΑ
Output	Collector dark current		ICEO	$V_{CE} = 20V$	-	1	100	nA
Transfer chara cteristics	Collector current		Ic	$V_{CE} = 5V, I_F = 20mA$	0.5	-	3.0	mA
	*2Leak current		I LEAK	$V_{CE} = 5V, I_F = 20mA$	-	-	500	nA
	*3Response time	Rise time	tr	$V_{CE} = 2V, I_C = 100 \mu A$	-	50	150	μs
		Fall time	tf	$R_{\rm L}\!=1~000\Omega$, $d\!=4mm$	-	50	150	μs

*2 No reflective object

*3"d" is glass thickness of reflective mirror.

Test Arrangement of Collector Current



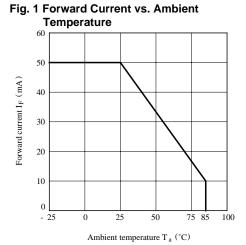


Fig. 2 Power Dissipation vs. Ambient Temperature

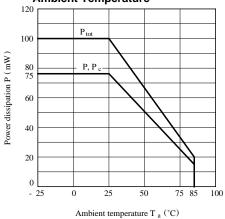
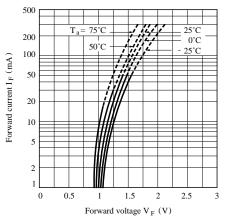
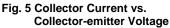
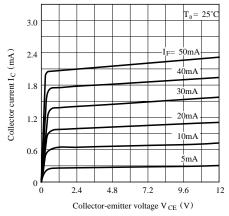


Fig. 3 Forward Current vs. Forward Voltage









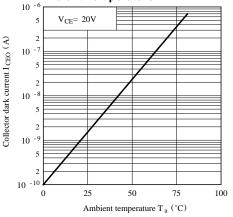


Fig. 4 Collector Current vs. Forward Current

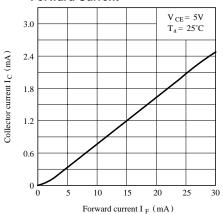


Fig. 6 Relative Collector Current vs. Ambient Temperature

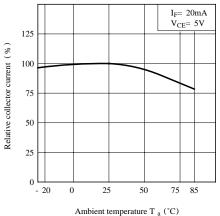
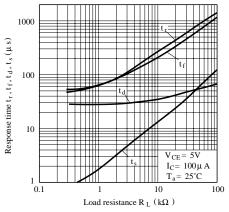
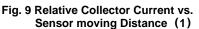


Fig. 8 Response Time vs. Load Resistance





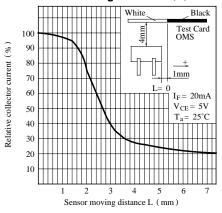
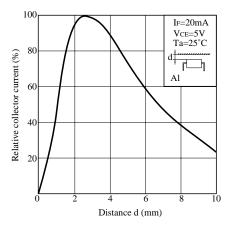
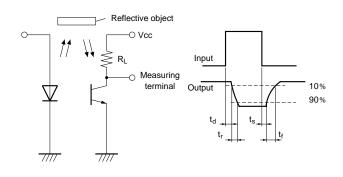


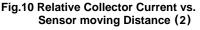
Fig. 11 Relative Collector Current vs. Distance

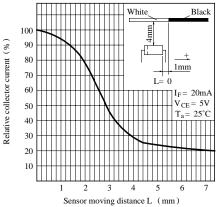


• Please refer to the chapter "Precautions for Use".

Test Circuit for Response Time







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 - Industrial control
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 - Consumer electronics

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- Gas leakage sensor breakers
- Alarm equipment
- Various safety devices, etc.

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